

To our customers,

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## Old Company Name in Catalogs and Other Documents

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April 1<sup>st</sup>, 2010  
Renesas Electronics Corporation

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**2088 PIXELS CCD LINEAR IMAGE SENSOR WITH PERIPHERAL CIRCUIT**
**DESCRIPTION**

The  $\mu$ PD3753 is a 2088-pixel high sensitivity CCD (Charge Coupled Device) linear image sensor which changes optical images to electrical signal.

The  $\mu$ PD3753 consists of 2088-pixels photocell array and a line of 2088-pixel CCD charge transferred register. It contains a reset a feed-through level clamp circuit, a reset pulse generator, a clamp pulse generator, and a voltage amplifier to provide high sensitivity and low noise. It also supports low power consumption with single 5 V power supply. The  $\mu$ PD3753 can be driven by power supply and three input clocks owing to the on-chip reset pulse generator and a clamp pulse generator.

**FEATURES**

- Valid photocell : 2088 pixels
- Photocell pitch : 14  $\mu$ m
- Peak response wavelength : 550 nm (green)
- Resolution : 8 dot/mm B4 (257  $\times$  364 mm) size (shorter side)
- High response sensitivity
- Low noise
- Drive clock level : CMOS output under +5 V operation
- Data rate : 2 MHz Max.
- Power supply : +5 V
- On-chip circuits : Reset feed-through level clamp circuit  
Reset pulse generator  
Clamp pulse generator  
Voltage amplifier

**ORDERING INFORMATION**

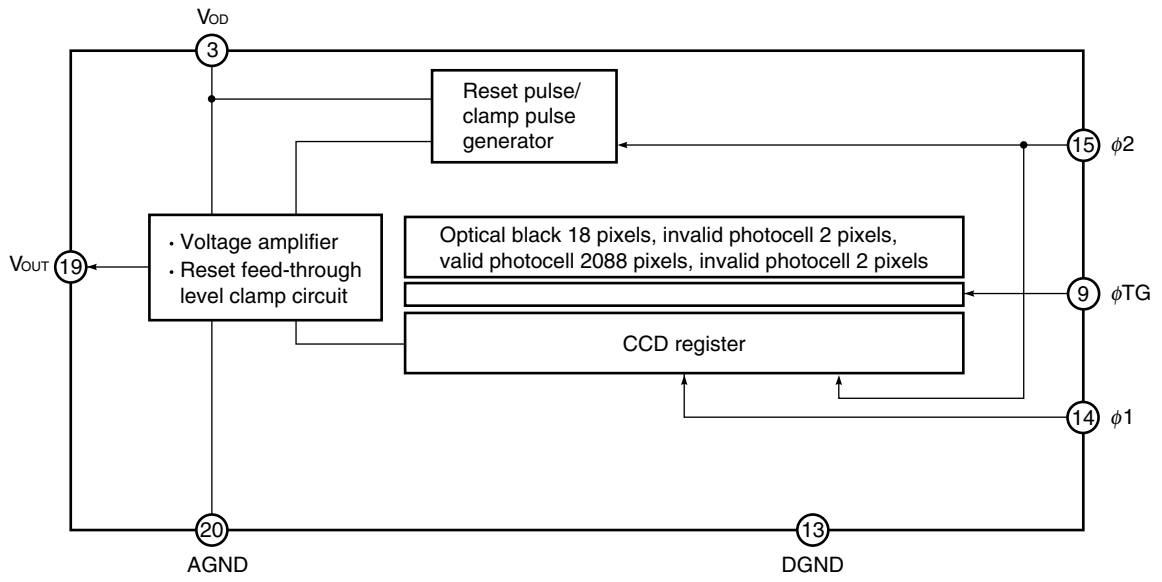
Part Number	Package
$\mu$ PD3753CY-A	CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))

<R> **Remark** The  $\mu$ PD3753CY-A is a lead-free product.

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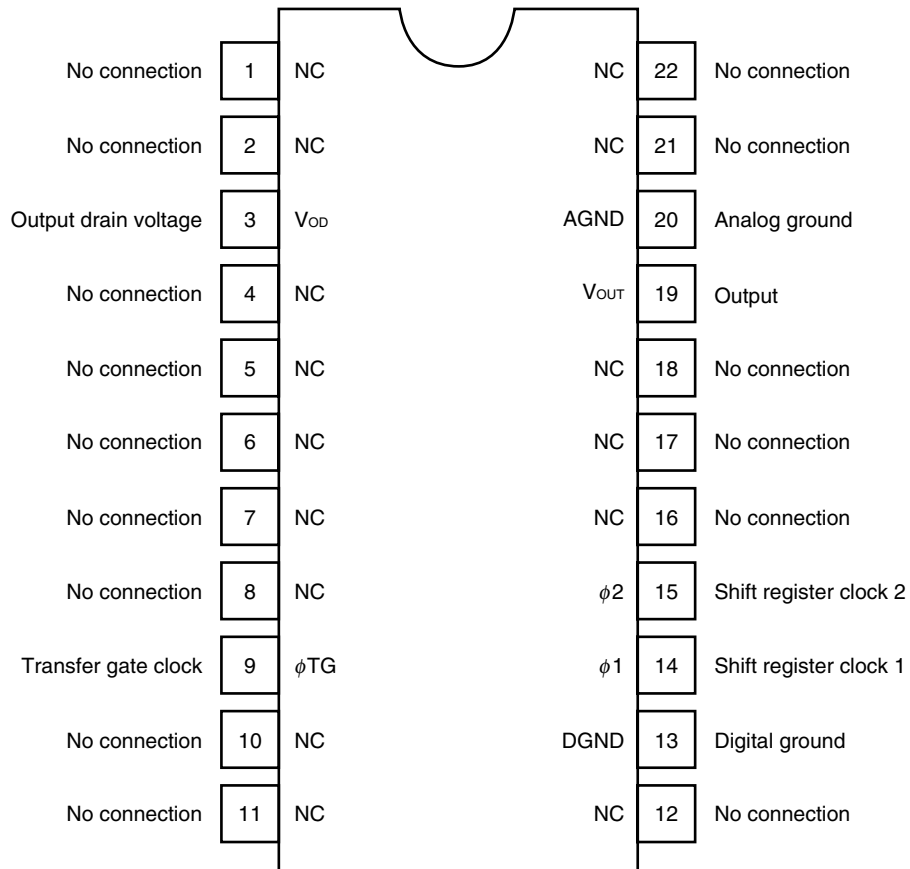
BLOCK DIAGRAM



**PIN CONFIGURATION (Top View)**

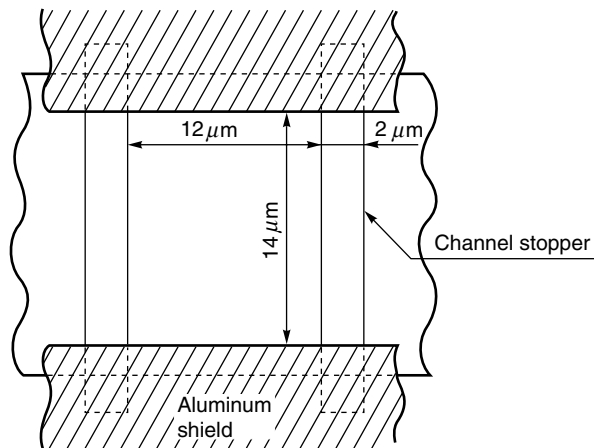
**CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))**

• μPD3753CY-A



**Caution** Connect the No connection pins (NC) to GND.

**PHOTOCELL STRUCTURE DIAGRAM**



**ABSOLUTE MAXIMUM RATINGS (TA = +25°C)**

Parameter	Symbol	Ratings	Unit
Output drain voltage	V <sub>OD</sub>	-0.3 to +8	V
Shift register clock voltage	V <sub>φ1</sub> , V <sub>φ2</sub>	-0.3 to +8	V
Transfer gate clock voltage	V <sub>φTG</sub>	-0.3 to +8	V
Operating ambient temperature <sup>Note</sup>	T <sub>A</sub>	-25 to +60	°C
Storage temperature	T <sub>stg</sub>	-40 to +70	°C

**Note** Use at the condition without dew condensation.

**Caution** Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

**RECOMMENDED OPERATING CONDITIONS (TA = +25°C)**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Output drain voltage	V <sub>OD</sub>	4.7	5.0	5.3	V
Shift register clock high level	V <sub>φ1_H</sub> , V <sub>φ2_H</sub>	4.5	5.0	V <sub>OD</sub> +0.2	V
Shift register clock low level	V <sub>φ1_L</sub> , V <sub>φ2_L</sub>	-0.3	0	+0.5	V
Transfer gate clock high level	V <sub>φTGH</sub>	4.5	V <sub>φ1_H</sub> <sup>Note</sup>	V <sub>φ1_H</sub> <sup>Note</sup>	V
Transfer gate clock low level	V <sub>φTGL</sub>	-0.3	0	+0.5	V
Data rate	f <sub>φR</sub>	0.2	1	2	MHz

**Note** When Transfer gate clock high level (V<sub>φTGH</sub>) is higher than Shift register clock high level (V<sub>φ1\_H</sub>), Image lag can increase.

**ELECTRICAL CHARACTERISTICS**

$T_A = +25^\circ\text{C}$ ,  $V_{OD} = 5\text{ V}$ ,  $f_{\phi 1} = 1\text{ MHz}$ , data rate = 1 MHz, storage time = 10 ms, input signal clock = 5 V<sub>p-p</sub>,  
light source : 3200 K halogen lamp + C500 (infrared cut filter)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Saturation voltage	V <sub>sat</sub>		1.0	1.2	–	V
Saturation exposure	SE	Daylight color fluorescent lamp	–	0.013	–	lx•s
Photo response non-uniformity	PRNU	V <sub>OUT</sub> = 500 mV	–	±2	±8	%
Average dark signal	ADS	Light shielding	–	1.0	8.0	mV
Dark signal non-uniformity	DSNU	Light shielding	–8	±4	+8	mV
Power consumption	P <sub>w</sub>		–	30	50	mW
Output impedance	Z <sub>o</sub>		–	0.5	1	kΩ
Response	R <sub>F</sub>	Daylight color fluorescent lamp	63	90	117	V/lx•s
Response peak			–	550	–	nm
Image lag	IL	V <sub>OUT</sub> = 1.0 V	–	7	14	%
Offset level <sup>Note</sup>	V <sub>OS</sub>		2.5	3.0	3.5	V
Output fall delay time <sup>Note</sup>	t <sub>d</sub>	V <sub>OUT</sub> = 500 mV, t <sub>1</sub> , t <sub>2</sub> = 50 ns	–	130	–	ns
Total transfer efficiency	TTE	V <sub>OUT</sub> = 1.0 V, data rate = 2 MHz	92	98	–	%
Dynamic range	DR	V <sub>sat</sub> /DSNU	–	375	–	times
Reset feed-through noise <sup>Note</sup>	RFTN	Light shielding	0	800	1500	mV
Bit noise	BN	Light shielding	–	10	–	mV <sub>p-p</sub>
Resolution	MTF	Modulation transfer function at nyquist frequency	–	65	–	%

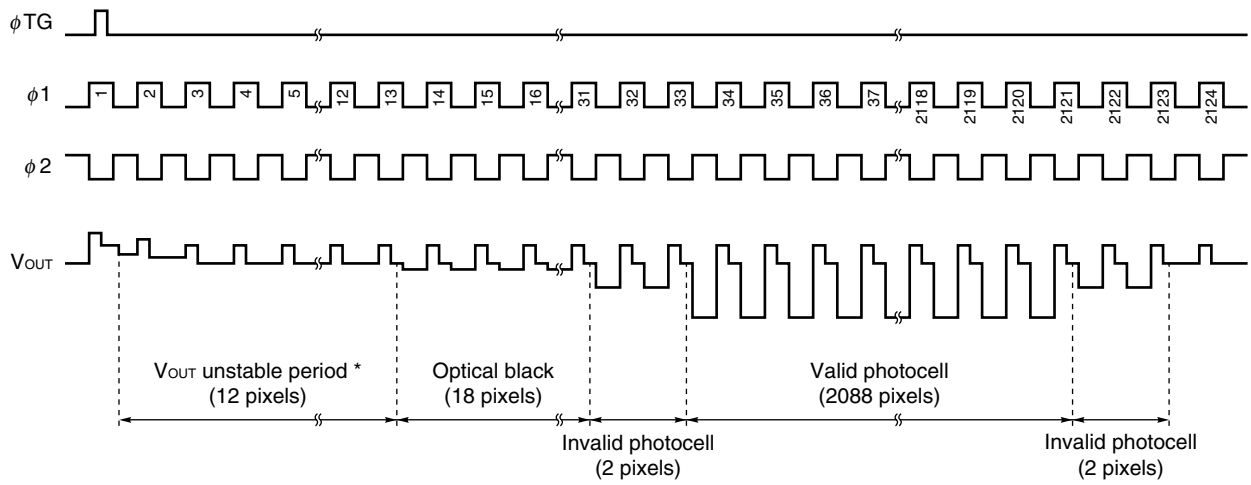
**Note** Refer to **TIMING CHART 2**.

**Remark** When V<sub>OD</sub> = 4.7 V, the response typically decreases to 90% of the value under 5 V operation.

**INPUT PIN CAPACITANCE (T<sub>A</sub> = +25°C, V<sub>OD</sub> = 5 V)**

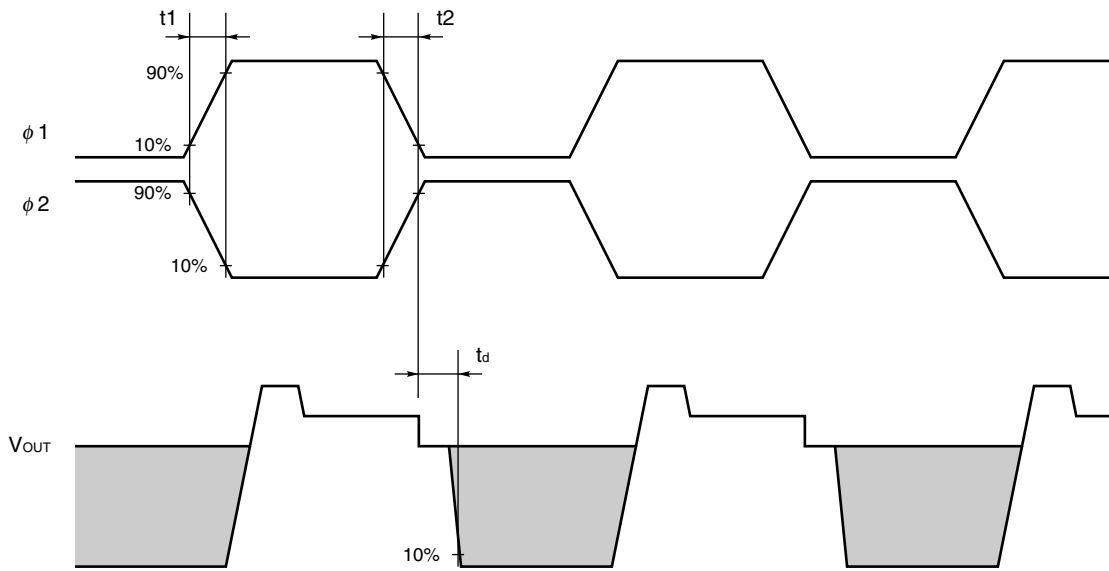
Parameter	Symbol	Pin name	Pin No.	Min.	Typ.	Max.	Unit
Shift register clock pin capacitance 1	C <sub>φ1</sub>	φ1	14	–	300	–	pF
Shift register clock pin capacitance 2	C <sub>φ2</sub>	φ2	15	–	300	–	pF
Transfer gate clock pin capacitance	C <sub>φTG</sub>	φTG	9	–	100	–	pF

**TIMING CHART 1**



**Caution** Be sure not to use this period (indicated by \*) as the black level, because this part is unstable.

**TIMING CHART 2**



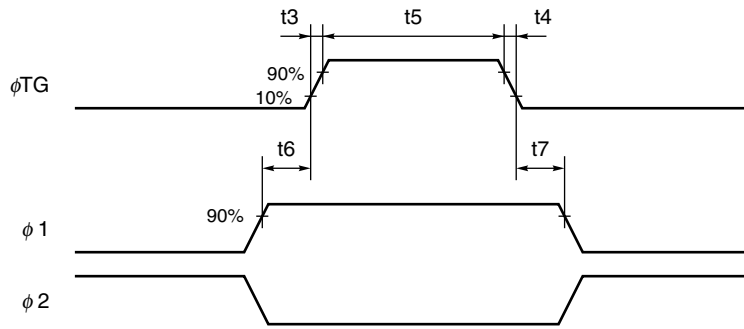
**Remark**  : Signal output

Symbol	Min.	Typ.	Max.	Unit
$t_1, t_2$	0	50	(100)	ns

**Remark** The MAX. in the table above shows the operation range in which the output characteristics are kept almost enough for general purpose, does not show the limit above which the μPD3753 is destroyed.



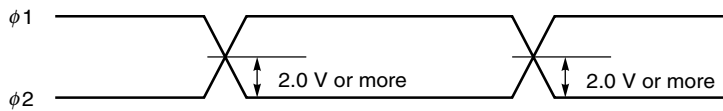
$\phi$ TG,  $\phi$ 1,  $\phi$ 2 TIMING CHART



Symbol	Min.	Typ.	Max.	Unit
t3, t4	0	50	–	ns
t5	650	1000	(2000)	ns
t6, t7	0	100	–	ns

**Remark** The MAX. in the table above shows the operation range in which the output characteristics are kept almost enough for general purpose, does not show the limit above which the  $\mu$ PD3753 is destroyed.

$\phi$ 1,  $\phi$ 2 cross points



**Remark** Adjust cross points  $\phi$ 1,  $\phi$ 2 with input resistance of each pin.

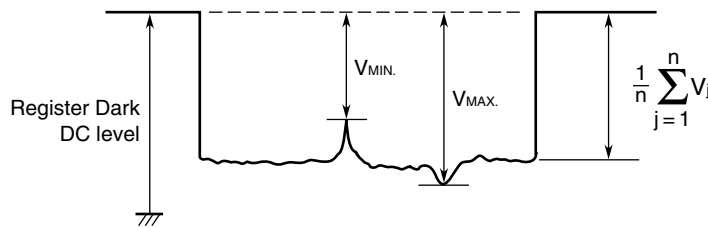
**DEFINITIONS OF CHARACTERISTIC ITEMS**

1. Saturation voltage : **V<sub>sat</sub>**  
Output signal voltage at which the response linearity is lost.
2. Saturation exposure : **SE**  
Product of intensity of illumination (lx) and storage time (s) when saturation of output voltage occurs.
3. Photo response non-uniformity : **PRNU**  
The peak/bottom ratio to the average output voltage of all the valid pixels calculated by the following formula.

$$PRNU (\%) = \left( \frac{V_{MAX. \text{ or } V_{MIN.}}}{\frac{1}{n} \sum_{j=1}^n V_j} - 1 \right) \times 100$$

n : Number of valid pixels

V<sub>j</sub> : Output voltage of each pixel

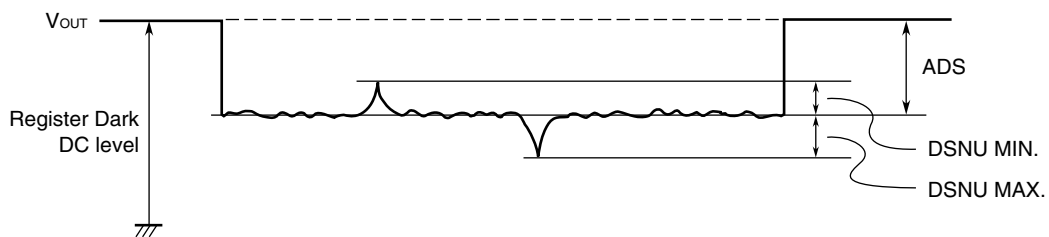


4. Average dark signal : **ADS**  
Average output signal voltage of all the valid pixels at light shielding. This is calculated by the following formula.

$$ADS (mV) = \frac{\sum_{j=1}^{2088} d_j}{2088}$$

d<sub>j</sub> : Dark signal of valid pixel number j

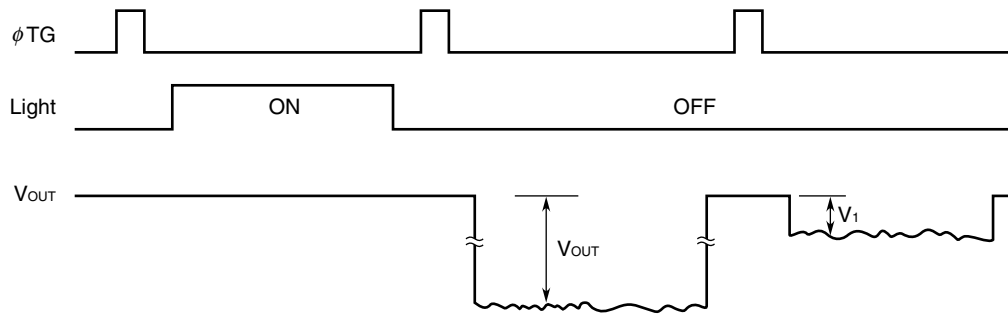
5. Dark signal non-uniformity : **DSNU**  
The difference between ADS and voltage of the highest or lowest output pixel of all the valid pixels at light shielding.



6. Output impedance : **Z<sub>o</sub>**  
 Impedance of the output pins viewed from outside.

7. Response : **R**  
 Output voltage divided by exposure (Ix•s).  
 Note that the response varies with a light source (spectral characteristic).

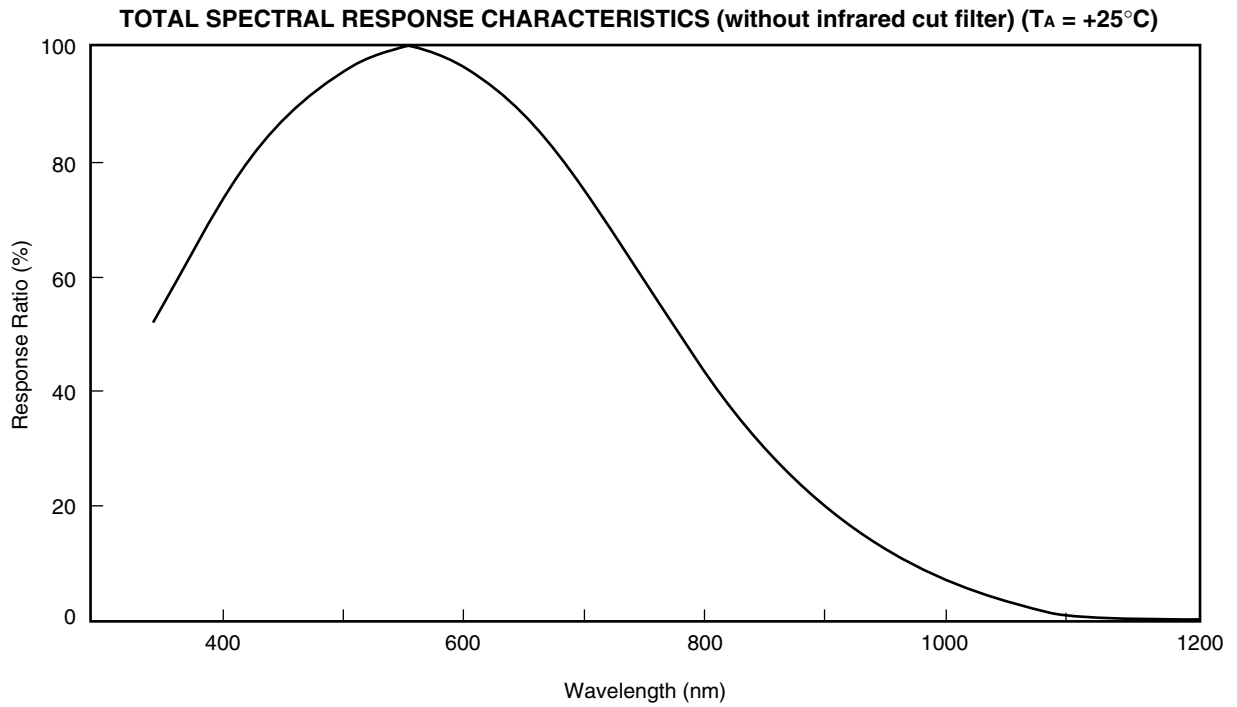
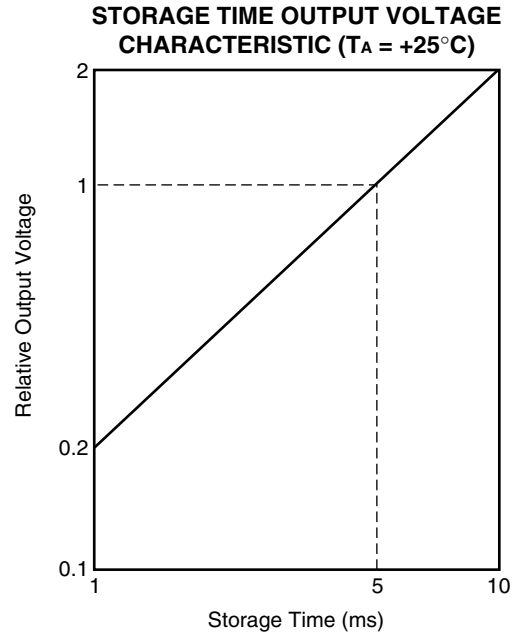
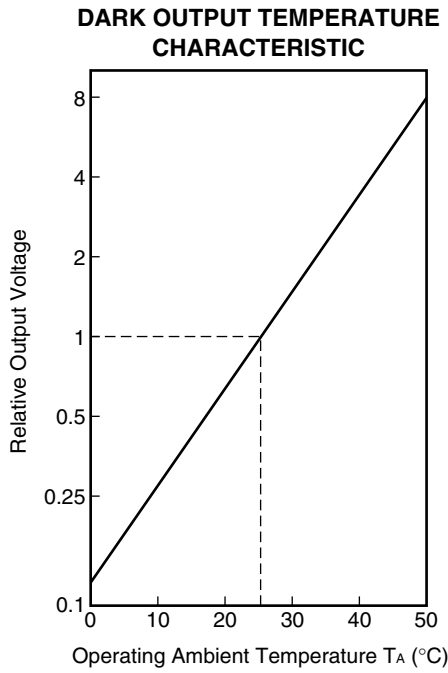
8. Image lag : **IL**  
 The rate between the last output voltage and the next one after read out the data of a line.

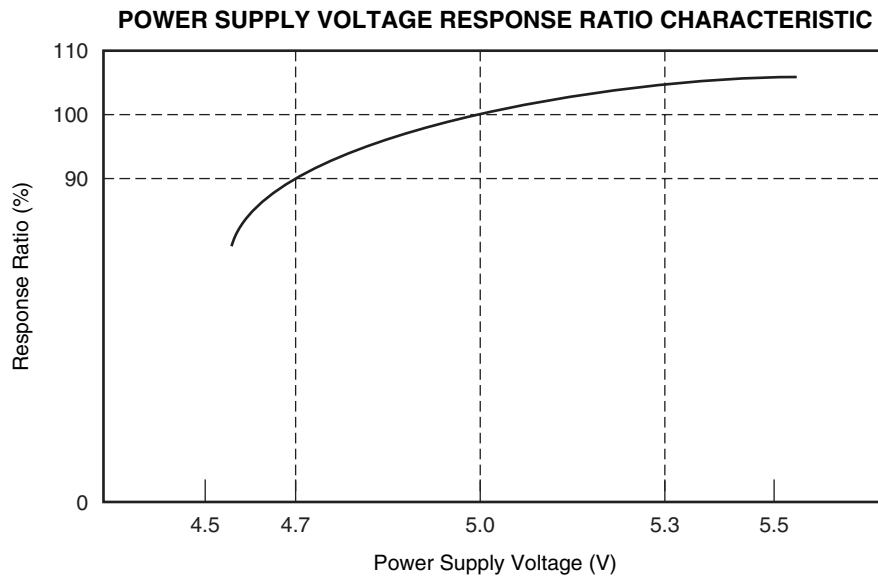


$$IL (\%) = \frac{V_1}{V_{OUT}} \times 100$$

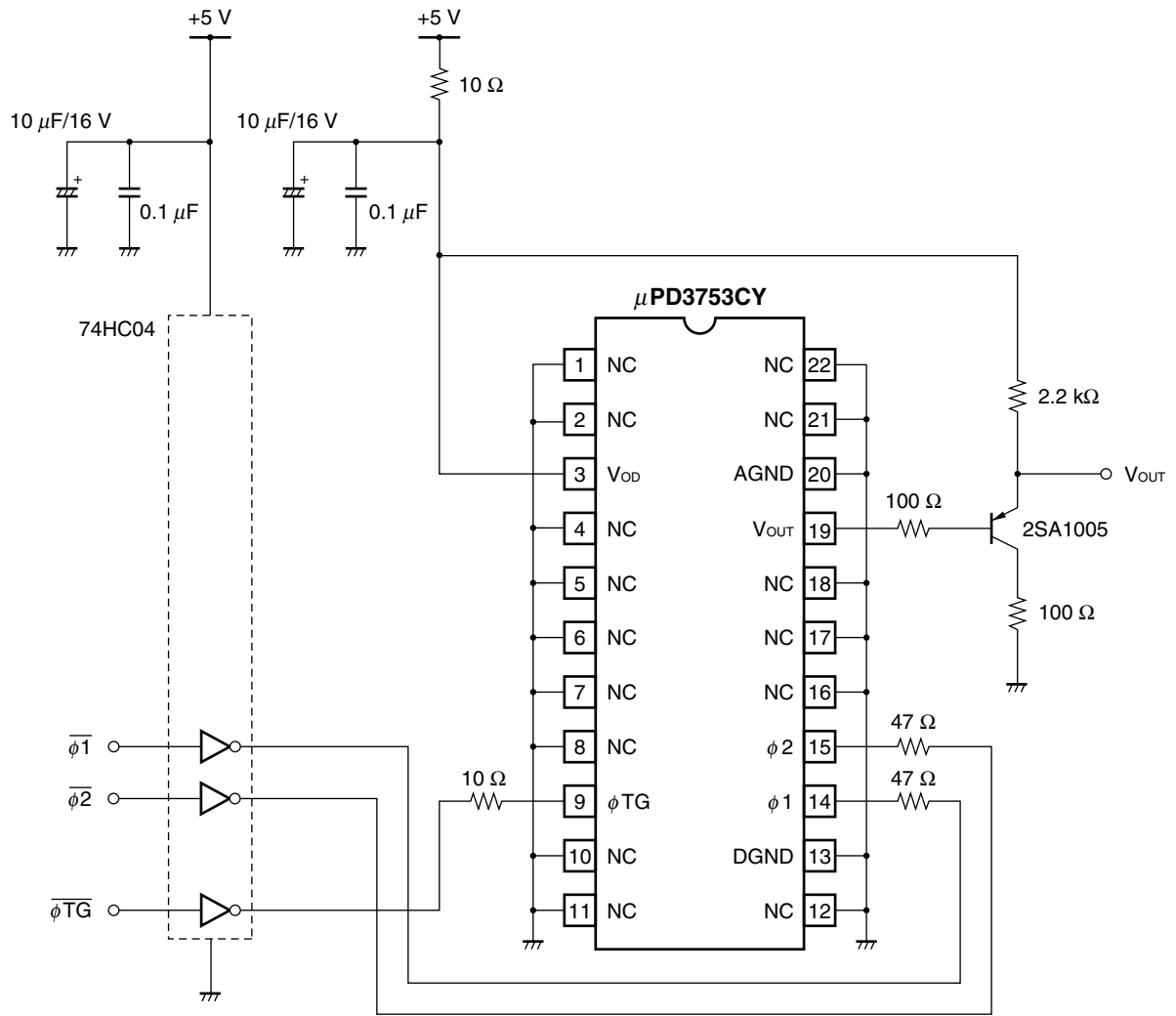
9. Bit Noise : **BN**  
 Output signal distribution of a photocell by scan.

STANDARD CHARACTERISTIC CURVES (Reference Value)





APPLICATION CIRCUIT EXAMPLE

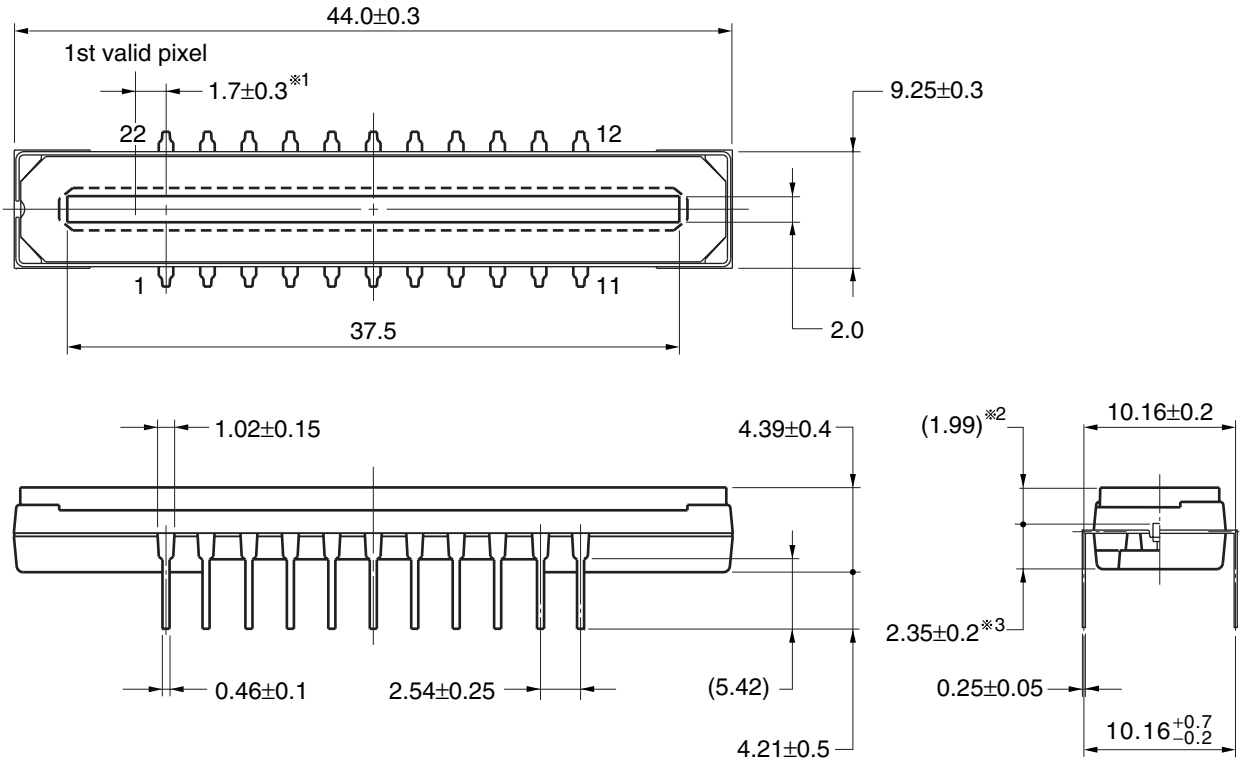


**Caution** Connect the No connection pins (NC) to GND.

PACKAGE DRAWING

μPD3753CY  
 CCD LINEAR IMAGE SENSOR 22-PIN PLASTIC DIP (10.16 mm (400) )

(Unit : mm)



Name	Dimensions	Refractive index
Plastic cap	42.9×8.35×0.7	1.5

- ※1 1st valid pixel ↔ The center of the pin1
- ※2 The surface of the CCD chip ↔ The top of the cap
- ※3 The bottom of the package ↔ The surface of the CCD chip

22C-1CCD-PKG15-1

**RECOMMENDED SOLDERING CONDITIONS**

When soldering this product, it is highly recommended to observe the conditions as shown below.

If other soldering processes are used, or if the soldering is performed under different conditions, please make sure to consult with our sales offices.

**Type of Through-hole Device**

**μPD3753CY-A : CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))**

Process	Conditions
Partial heating method	Pin temperature : 300 °C or below, Heat time : 3 seconds or less (per pin)

- Cautions**
1. **During assembly care should be taken to prevent solder or flux from contacting the plastic cap. The optical characteristics could be degraded by such contact.**
  2. **Soldering by the solder flow method may have deleterious effects on prevention of plastic cap soiling and heat resistance. So the method cannot be guaranteed.**



**NOTES ON HANDLING THE PACKAGES**

**① DUST AND DIRT PROTECTING**

The optical characteristics of the CCD will be degraded if the cap is scratched during cleaning. Don't either touch plastic cap surface by hand or have any object come in contact with plastic cap surface. Should dirt stick to a plastic cap surface, blow it off with an air blower. For dirt stuck through electricity ionized air is recommended. And if the plastic cap surface is grease stained, clean with our recommended solvents.

**○ CLEANING THE PLASTIC CAP**

Care should be taken when cleaning the surface to prevent scratches.

We recommend cleaning the cap with a soft cloth moistened with one of the recommended solvents below. Excessive pressure should not be applied to the cap during cleaning. If the cap requires multiple cleanings it is recommended that a clean surface or cloth be used.

**○ RECOMMENDED SOLVENTS**

The following are the recommended solvents for cleaning the CCD plastic cap.

Use of solvents other than these could result in optical or physical degradation in the plastic cap. Please consult your sales office when considering an alternative solvent.

Solvents	Symbol
Ethyl Alcohol	EtOH
Methyl Alcohol	MeOH
Isopropyl Alcohol	IPA
N-methyl Pyrrolidone	NMP

**② MOUNTING OF THE PACKAGE**

The application of an excessive load to the package may cause the package to warp or break, or cause chips to come off internally. Particular care should be taken when mounting the package on the circuit board. Don't have any object come in contact with plastic cap. You should not reform the lead frame. We recommended to use a IC-inserter when you assemble to PCB.

Also, be care that the any of the following can cause the package to crack or dust to be generated.

1. Applying heat to the external leads for an extended period of time with soldering iron.
2. Applying repetitive bending stress to the external leads.
3. Rapid cooling or heating

**③ OPERATE AND STORAGE ENVIRONMENTS**

Operate in clean environments. CCD image sensors are precise optical equipment that should not be subject to mechanical shocks. Exposure to high temperatures or humidity will affect the characteristics. So avoid storage or usage in such conditions.

Keep in a case to protect from dust and dirt. Dew condensation may occur on CCD image sensors when the devices are transported from a low-temperature environment to a high-temperature environment. Avoid such rapid temperature changes.

For more details, refer to our document "Review of Quality and Reliability Handbook" (C12769E)

**④ ELECTROSTATIC BREAKDOWN**

CCD image sensor is protected against static electricity, but destruction due to static electricity is sometimes detected. Before handling be sure to take the following protective measures.

1. Ground the tools such as soldering iron, radio cutting pliers of or pincer.
2. Install a conductive mat or on the floor or working table to prevent the generation of static electricity.
3. Either handle bare handed or use non-chargeable gloves, clothes or material.
4. Ionized air is recommended for discharge when handling CCD image sensor.
5. For the shipment of mounted substrates, use box treated for prevention of static charges.
6. Anyone who is handling CCD image sensors, mounting them on PCBs or testing or inspecting PCBs on which CCD image sensors have been mounted must wear anti-static bands such as wrist straps and ankle straps which are grounded via a series resistance connection of about 1 MΩ.

[MEMO]

[MEMO]

[MEMO]

## NOTES FOR CMOS DEVICES

**① VOLTAGE APPLICATION WAVEFORM AT INPUT PIN**

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between  $V_{IL}$  (MAX) and  $V_{IH}$  (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between  $V_{IL}$  (MAX) and  $V_{IH}$  (MIN).

**② HANDLING OF UNUSED INPUT PINS**

Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to  $V_{DD}$  or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.

**③ PRECAUTION AGAINST ESD**

A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.

**④ STATUS BEFORE INITIALIZATION**

Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.

**⑤ POWER ON/OFF SEQUENCE**

In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current.

The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.

**⑥ INPUT OF SIGNAL DURING POWER OFF STATE**

Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

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"Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.

"Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).

"Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

(Note)

- (1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).